

**Search Notes**

Application/Control No.

10/785,153

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

ISHIKAWA ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	383	9/30/2005	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
707/101 (see printouts)	9/30/2005	SHL